	Type	L #	Hits	Search Text	DBs	Time Stamp	mm en ts	fi	1 1
1	BRS	L1	24	<pre>(wafer near inspect\$) same intensity same defect</pre>	USPAT	2002/11/07 10:33			0
2	BRS	L2	1	5699447.pn.	USPAT	2002/11/07 09:23			0
3	BRS	L3	75	(wafer same inspect\$) same intensity same defect	USPAT	2002/11/07 10:33			0